

MOS FIELD EFFECT POWER TRANSISTOR  
**2SK1594**

**SWITCHING**  
**N-CHANNEL POWER MOS FET**  
**INDUSTRIAL USE**

**DESCRIPTION**

The 2SK1594 is N-channel MOS Field Effect Transistor designed for solenoid, motor and lamp driver.

**FEATURES**

- Low On-state Resistance  
 $R_{DS(on)} \leq 0.080 \Omega$  ( $V_{GS} = 4 V, I_D = 10 A$ )  
 $R_{DS(on)} \leq 0.045 \Omega$  ( $V_{GS} = 10 V, I_D = 10 A$ )
- Low  $C_{iss}$   $C_{iss} = 1\ 200\ pF$  TYP.
- Built-in G-S Gate Protection Diode

**QUALITY GRADE**

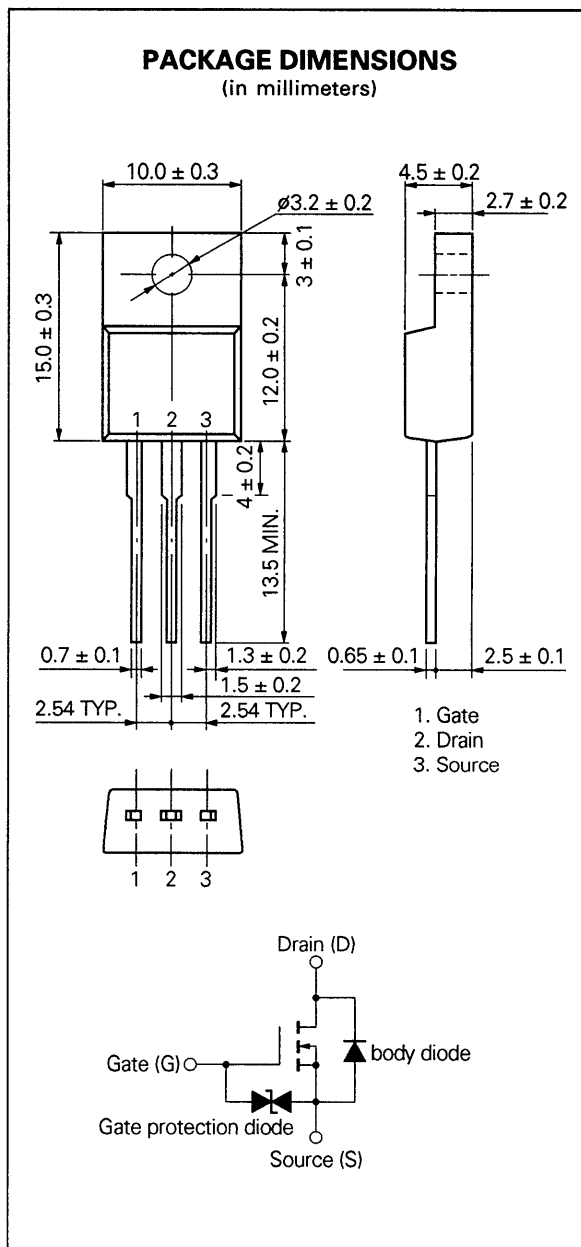
Standard

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

**ABSOLUTE MAXIMUM RATINGS ( $T_a = 25\ ^\circ C$ )**

Drain to Source Voltage	$V_{DSS}$	30	V
Gate to Source Voltage	$V_{GSS(AC)}$	$\pm 20$	V
Drain Current (DC)	$I_{D(DC)}$	$\pm 20$	A
Drain Current (pulse)	$I_{D(pulse)^*}$	$\pm 80$	A
Total Power Dissipation ( $T_c = 25\ ^\circ C$ )	$P_{T1}$	30	W
Total Power Dissipation ( $T_a = 25\ ^\circ C$ )	$P_{T2}$	2.0	W
Channel Temperature	$T_{ch}$	150	$^\circ C$
Storage Temperature	$T_{stg}$	-55 to +150	$^\circ C$

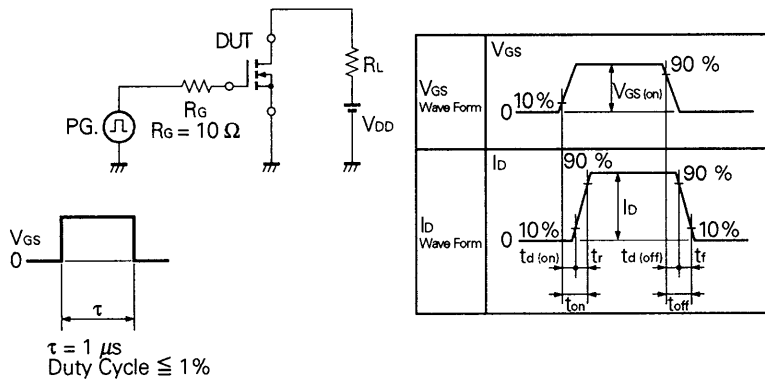
\*  $PW \leq 10\ \mu s, Duty\ Cycle \leq 2\ %$



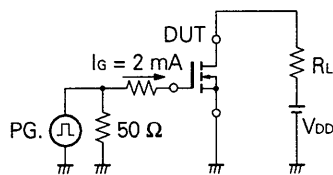
**ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25 °C)**

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Drain to Source On-state Resistance	R <sub>DS(on)</sub>		0.045	0.08	Ω	V <sub>GS</sub> = 4 V, I <sub>D</sub> = 10 A
Drain to Source On-state Resistance	R <sub>DS(on)</sub>		0.03	0.045	Ω	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A
Gate to Source Cutoff Voltage	V <sub>GS(off)</sub>	1.0		2.5	V	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA
Forward Transfer Admittance	y <sub>fs</sub>	7			S	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 10 A
Drain Leakage Current	I <sub>DSS</sub>			10	μA	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0
Gate to Source Leakage Current	I <sub>GSS</sub>			±10	μA	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0
Input Capacitance	C <sub>iss</sub>		1 200		pF	V <sub>DS</sub> = 10 V V <sub>GS</sub> = 0 f = 1 MHz
Output Capacitance	C <sub>oss</sub>		750		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>		280		pF	
Turn-On Delay Time	t <sub>d(on)</sub>		30		ns	V <sub>GS(on)</sub> = 10 V V <sub>DD</sub> = 15 V I <sub>D</sub> = 10 A, R <sub>G</sub> = 10 Ω R <sub>L</sub> = 1.5 Ω
Rise Time	t <sub>r</sub>		360		ns	
Turn-Off Delay Time	t <sub>d(off)</sub>		190		ns	
Fall Time	t <sub>f</sub>		220		ns	
Total Gate Charge	Q <sub>G</sub>		35		nC	V <sub>GS</sub> = 10 V I <sub>D</sub> = 20 A V <sub>DD</sub> = 30 V
Gate to Source Charge	Q <sub>GS</sub>		4		nC	
Gate to Drain Charge	Q <sub>GD</sub>		12		nC	
Diode Forward Voltage	V <sub>SD</sub>		1.0		V	I <sub>F</sub> = 20 A, V <sub>GS</sub> = 0
Reverse Recovery Time	t <sub>rr</sub>		110		ns	I <sub>F</sub> = 20 A, V <sub>GS</sub> = 0 di/dt = 50 A/μs
Reverse Recovery Charge	Q <sub>rr</sub>		200		nC	

**Test Circuit 1: Switching Time**

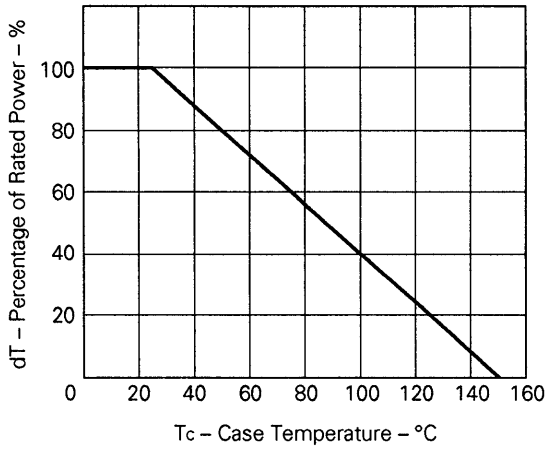


**Test Circuit 2: Gate Charge**

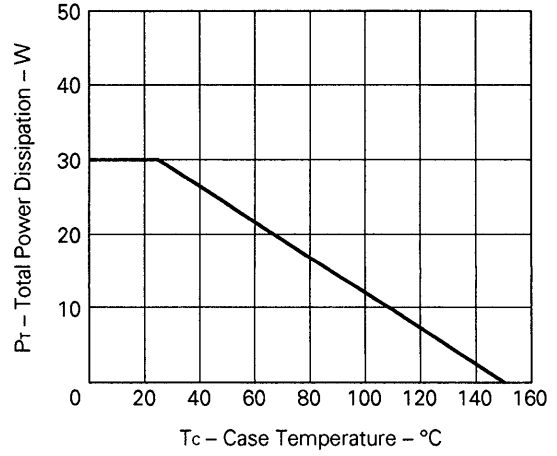


TYPICAL CHARACTERISTICS ( $T_a = 25^\circ\text{C}$ )

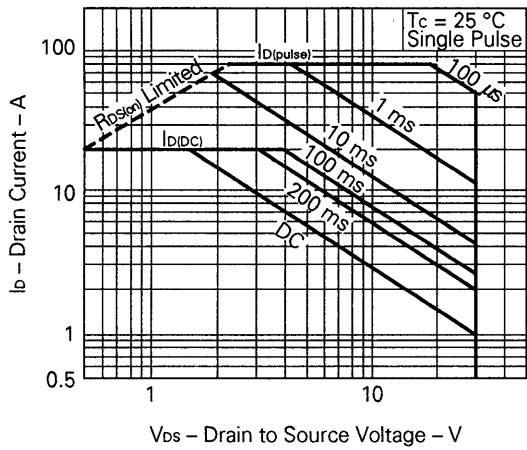
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



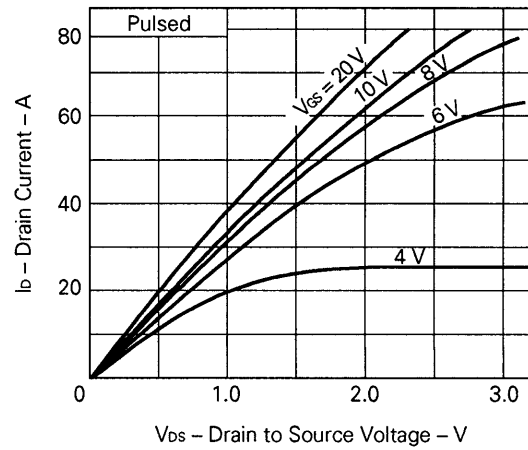
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



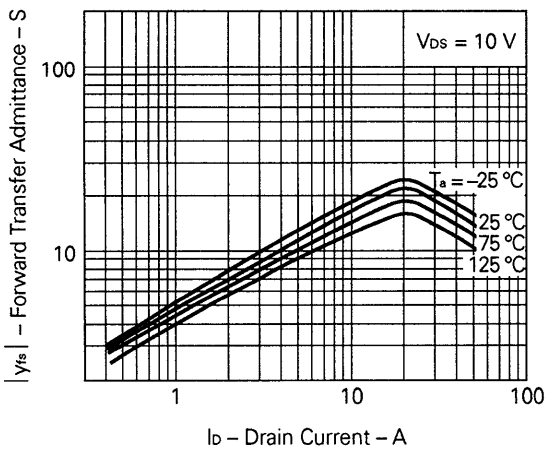
FORWARD BIAS SAFE OPERATING AREA



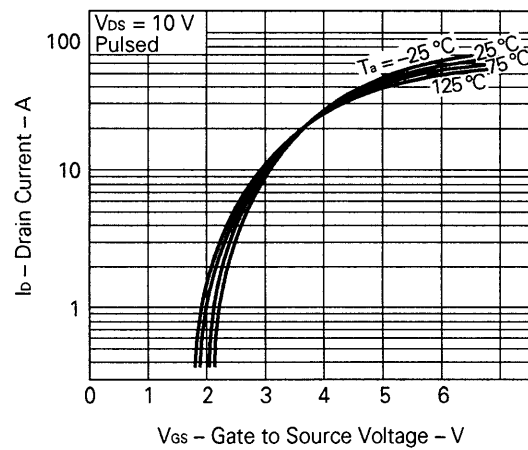
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

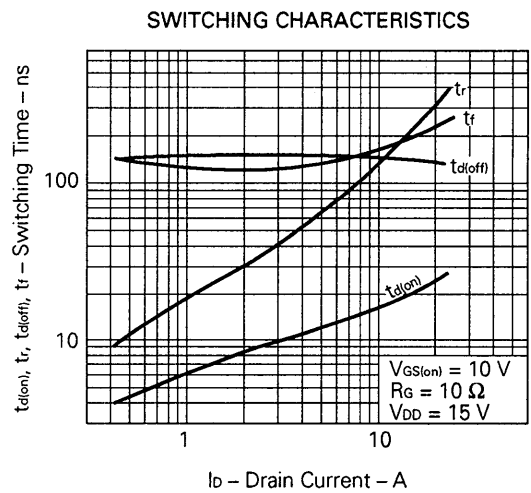
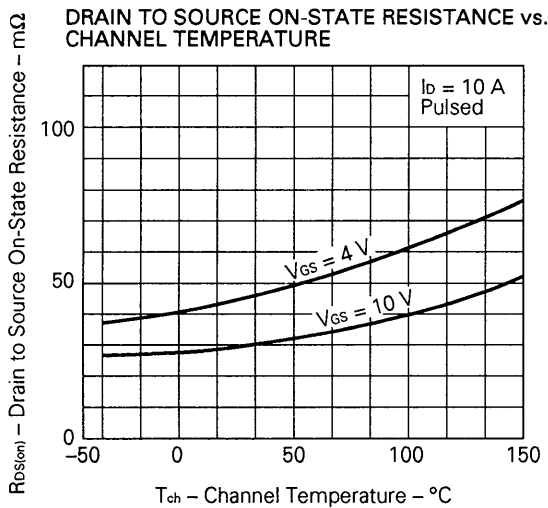
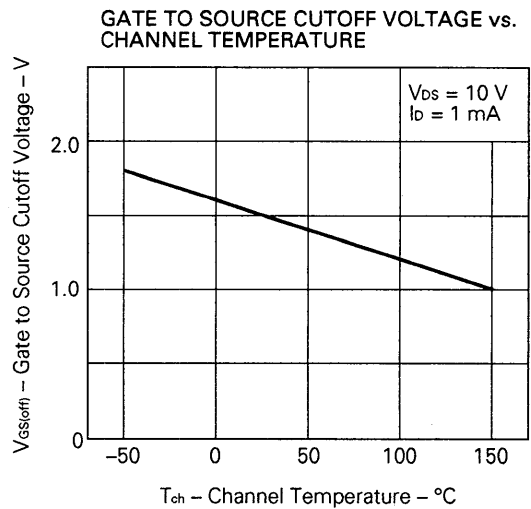
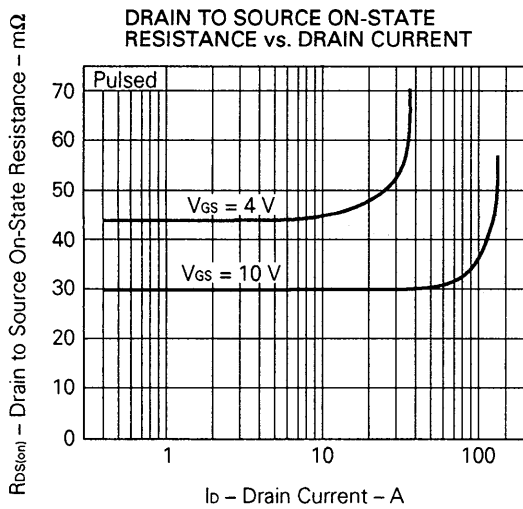
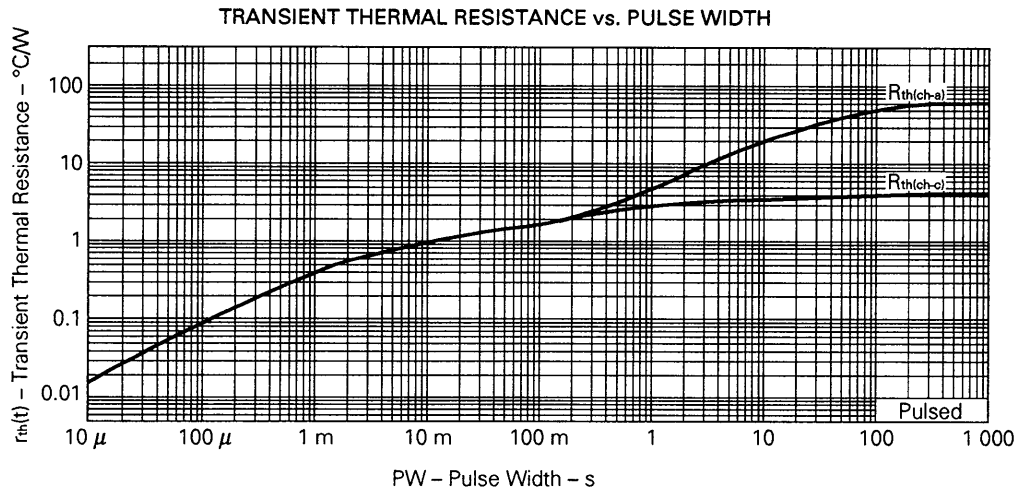


FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

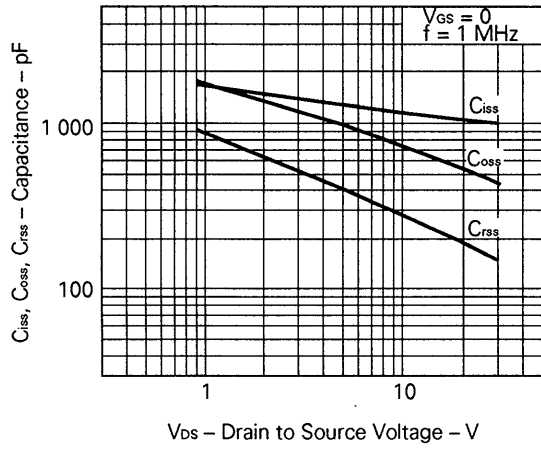


TRANSFER CHARACTERISTICS

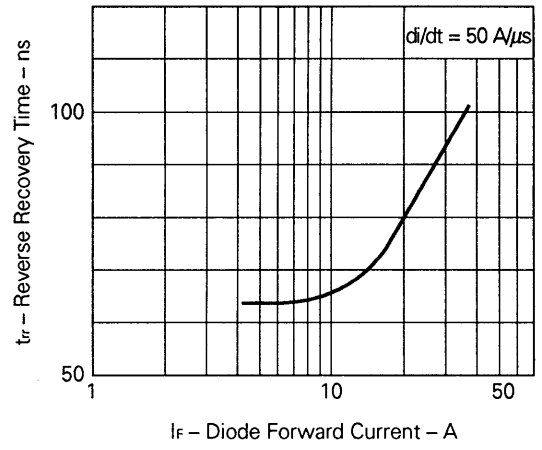




CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



**Reference**

Application note name	No.
Safe operating area of Power MOS FET.	TEA-1034
Application circuit using Power MOS FET.	TEA-1035
Quality control of NEC semiconductors devices.	TEI-1202
Quality control guide of semiconductors devices.	MEI-1202
Assembly manual of semiconductors devices.	IEI-1207

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